

Best suited for measuring magnetic properties of soft magnetic materials such as silicon steel plates, ferrites, and amorphous materials



- B-H Analyzer SY-8219
- Measurement frequency: 10Hz to 10MHz(SY-8218), 10Hz to 1MHz(SY-8219)
- Equipped Pulse excitation signal (Duty 50:50) output
- USB port is provided for copying the screen and saving data
- Optional Items

Power Amplifiers

DC bias power supply*

Single plate measurement function*

Low frequency excitation*

Scanner Chamber System for temperature characteristics test



Main features

- ① 10Hz to 10MHz(SY-8218) wide measurement frequency for evaluation of materials which are used in high-frequency (10Hz to 1MHz: SY-8219).
- ② High precision measurement with sufficient resolution (16 bits) and accuracy compensation in the frequency domain (CROSS-POWER method)
- 3 Simultaneous display of the reference and measured waveforms

■ Main specifications

	SY-8218	SY-8219
Measurement method	CROSS-POWER method (conformance to IEC62044-3)	
Measurement mode	B-H measurement, Pc measurement, μ measurement	
	Characteristics value B-H measurement: Max. magnetic flux density (Br), max. magnetic field (Hm), coercive force (Hc), squareness ratio (Br/Bm), amplitude permeability (μ a), core loss (Pc, Pcv, Pcm), current/voltage phase (θ), total magnetic flux change (2Φ m)	
Measurement item	Pc measurement : Max. magnetic flux density (Bm), residual magnetic flux density (Br), max. magnetic field (Hm), coercive force (Hc), amplitude permeability (μ a), core loss (Pc, Pcv, Pcm), phase (θ), apparent power (VA)	
	μ measurement : Max. magnetic flux density (Bm), max. magnetic field (Hm), impedance permeability (μz), complex permeability (μ, μ"), amplitude permeability (μa), core loss (Pc), phase (θ), loss coefficient (tan δ), inductance (L), resistance (R), impedance (Z), quality coefficient (Q)	
Waveform display	B-H curve, waveforms of excitation current, induced voltage, magnetic field, magnetic flux density	
Measurement frequency	10Hz ∼ 10MHz	10Hz ∼ 1MHz
Magnetic field signal detection	Voltage drop at both edges of non-inductive resistor Maximum signal detection current: 6A	
Magnetic flux density signal detection	Voltage detection at both edges of induced voltage detection coil Maximum signal detection voltage: $\pm 200~\mathrm{V}$	
Digitizer resolution	16 bits (8,192 points/cycle)	
Sample connection method	2 or 1 wire method	
Display	Color LCD display (800 x 600 pixels)	
Power supply	AC100 V to 240 V, 50/60 Hz, Power consumption: Approx. 130 VA MAX	
Weight and dimensions	Main unit: Approx. 12.5 kg, 420 (W) x 266 (H) x 480 (L) \pm 2 mm (without the projection section)	
Interface	USB (data storage)	

■Options

Opitons & system example of B-H Analyzers

DC Bias Power Supply

SY-931

Suitable for evaluation of minor loop loss under DC bias.

Current putput : 10A max, 1mH Frequency : 1MHz max



Constant Temperature Chamber Scanner System

SY-320 / SY-321

 For evaluation of temperature characteristics of magnetic material. Automatic measurement by the SY-810 (option software) can be performed.

Temperature range : -30°C to +150°C Max. number of samples 20 : SY320 Max. number of samples 41 : SY-321 GPIB interface for remote control



■Options

Single Plate Measurement Jig

SY-937 Custom Order

 For μ,iron loss and B-H curve measurement of silicon steel plates which are used for motors, solenoids, actuators and sensors.

Sample size : Thickness 0.2mm to 1.0mm Width 10mm to 30mm Length 60mm or more

Measurement frequencies: 50Hz, 60Hz



Turntable

SY-510 / SY-511

For automatic measurement of multiple samples.

Max. number of samples 20 : SY-510 Max. number of samples 41 : SY-511



Power Amplifier

HSA4101-IW

 For excitation of measurement samples.

DC to 10MHz, ±1A, ±70V, 50VA



Power Amplifier

HSA4014-IW

 For excitation of measurement samples.

DC to 1MHz, ±5A, ±75V, 200VA



Temperature chamber for measuremant of magnetic properties in high temperature

IE-1210

■ High temperature chamber system. Room temperature to +300°C



Power Amplifier

IE-1125

 For excitation of measurement samples.

DC to 3MHz, ±5A, ±140V, 350VA



PC Software

SY-810*

 Automatic programmable measurement software.

(included SY-509 and Bulk Head [female to female] Adaptor)

*PC software SY-810 requires an optional control
PC with USB-GPIB interface manufactured by Mational



USB-GPIB conversion adaptor

SY-509

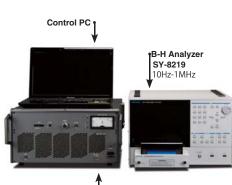
(Standard accessory for SY-810)



Example of Full-automatic B-H Analyzer with Constant Temperature Scanner System for various evaluations

- Temperature range : -30°C to +150°C
- Max. number of samples 20: SY-320
 Max. number of samples 41: SY-321

Remote control PC software SY-810(option)



Power Amplifier IE-1125 350VA,140V,5A



Constant Temperature Chamber Scanner System SY-321 for Max. 41 samples

Temperature range : -30°C to +150°C Max. number of samples 20 : SY320

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